

Notice of References Cited	Application/Control No. 10/511,525	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Rita J. Desai	Art Unit 1625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,569,865	05-2003	Eifion, Phillips	514/278
*	D	US-2003/0149065	08-2003	Loch III et al.	514/278
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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